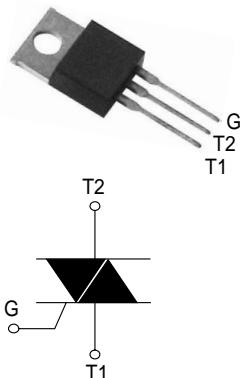
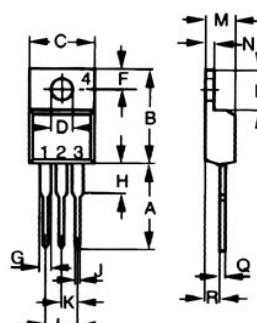


# BTB/BTA10

## Discrete Triacs(Non-Isolated/Isolated)



Dimensions TO-220AB



Dim.	Inches Min.	Inches Max.	Milimeter Min.	Milimeter Max.
A	0.500	0.550	12.70	13.97
B	0.580	0.630	14.73	16.00
C	0.390	0.420	9.91	10.66
D	0.139	0.161	3.54	4.08
E	0.230	0.270	5.85	6.85
F	0.100	0.125	2.54	3.18
G	0.045	0.065	1.15	1.65
H	0.110	0.230	2.79	5.84
J	0.025	0.040	0.64	1.01
K	0.100	BSC	2.54	BSC
M	0.170	0.190	4.32	4.82
N	0.045	0.055	1.14	1.39
Q	0.014	0.022	0.35	0.56
R	0.090	0.110	2.29	2.79

### ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter			Value	Unit
$I_T(\text{RMS})$	RMS on-state current (full sine wave)	TO-220AB	$T_c = 105^\circ\text{C}$	10	A
$I_{TSM}$	Non repetitive surge peak on-state current (full cycle, $T_j$ initial = $25^\circ\text{C}$ )	$F = 60 \text{ Hz}$	$t = 16.7 \text{ ms}$	105	A
		$F = 50 \text{ Hz}$	$t = 20 \text{ ms}$	100	
$I^2t$	$I^2t$ Value for fusing	$t_p = 10 \text{ ms}$		55	$\text{A}^2\text{s}$
$dI/dt$	Critical rate of rise of on-state current $I_G = 2 \times I_{GT}$ , $t_r \leq 100 \text{ ns}$	$F = 120 \text{ Hz}$	$T_j = 125^\circ\text{C}$	50	$\text{A}/\mu\text{s}$
$V_{DSM}/V_{RSM}$	Non repetitive surge peak off-state voltage	$t_p = 10 \text{ ms}$	$T_j = 25^\circ\text{C}$	$V_{DRM}/V_{RRM} + 100$	V
$I_{GM}$	Peak gate current	$t_p = 20 \mu\text{s}$	$T_j = 125^\circ\text{C}$	4	A
$P_{G(AV)}$	Average gate power dissipation	$T_j = 125^\circ\text{C}$		1	W
$T_{stg}$ $T_j$	Storage junction temperature range Operating junction temperature range			- 40 to + 150 - 40 to + 125	$^\circ\text{C}$

### ELECTRICAL CHARACTERISTICS ( $T_j = 25^\circ\text{C}$ , unless otherwise specified)

#### ■ SNUBBERLESS™ and LOGIC LEVEL(3 Quadrants)

Symbol	Test Conditions	Quadrant	BTA/BTB		Unit
			CW	BW	
$I_{GT}(1)$	$V_D = 12 \text{ V}$ $R_L = 33 \Omega$	I - II - III	MAX.	35	mA
		I - II - III	MAX.	1.3	
$V_{GD}$	$V_D = V_{DRM}$ $R_L = 3.3 \text{ k}\Omega$ $T_j = 125^\circ\text{C}$	I - II - III	MIN.	0.2	V
$I_H(2)$	$I_T = 500 \text{ mA}$		MAX.	35	mA
$I_L$	$I_G = 1.2 I_{GT}$	I - III	MAX.	50	mA
		II		60	
$dV/dt(2)$	$V_D = 67\% V_{DRM}$ gate open $T_j = 125^\circ\text{C}$		MIN.	500	$\text{V}/\mu\text{s}$
( $dI/dt$ )c(2)	Without snubber	$T_j = 125^\circ\text{C}$	MIN.	5.5	$\text{A}/\text{ms}$

# BTB/BTA10

## Discrete Triacs(Non-Isolated/Isolated)

### ■ STANDARD (4 Quadrants)

Symbol	Test Conditions	Quadrant		Value	Unit
I <sub>GT</sub> (1)	V <sub>D</sub> = 12 V    R <sub>L</sub> = 33 Ω	I - II - III	MAX.	50	mA
V <sub>GT</sub>		IV	MAX.	100	
V <sub>GD</sub>	V <sub>D</sub> = V <sub>DRM</sub> R <sub>L</sub> = 3.3 Ω    T <sub>j</sub> = 125°C	ALL	MIN.	0.2	V
I <sub>H</sub> (2)	I <sub>T</sub> = 500 mA		MAX.	50	mA
I <sub>L</sub>	I <sub>G</sub> = 1.2 I <sub>GT</sub>	I - III - IV	MAX.	50	mA
		II		100	
dV/dt (2)	V <sub>D</sub> = 67 % V <sub>DRM</sub> gate open    T <sub>j</sub> = 125°C		MIN.	400	V/μs
(dV/dt)c (2)	(dI/dt)c = 4.4 A/ms    T <sub>j</sub> = 125°C		MIN.	10	V/μs

### STATIC CHARACTERISTICS

Symbol	Test Conditions			Value	Unit
V <sub>TM</sub> (2)	I <sub>TM</sub> = 14 A    tp = 380 μs	T <sub>j</sub> = 25°C	MAX.	1.55	V
V <sub>to</sub> (2)	Threshold voltage	T <sub>j</sub> = 125°C	MAX.	0.85	V
R <sub>d</sub> (2)	Dynamic resistance	T <sub>j</sub> = 125°C	MAX.	40	mΩ
I <sub>DRM</sub>	V <sub>DRM</sub> = V <sub>RRM</sub>	T <sub>j</sub> = 25°C	MAX.	5	μA
		T <sub>j</sub> = 125°C		1	mA

Note 1: minimum IGT is guaranteed at 5% of IGT max.

Note 2: for both polarities of A2 referenced to A1

### THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
R <sub>th(j-c)</sub>	Junction to case (AC)	1.5	°C/W
R <sub>th(j-a)</sub>	Junction to ambient	60	°C/W

### PRODUCT SELECTOR

Part Number	Voltage (xxx)		Sensitivity	Type	Package
	200 V ~ 1000 V				
BTBV/BTA10	X	X	50 mA	Standard	TO-220AB

### OTHER INFORMATION

Part Number	Marking	Weight	Base quantity	Packing mode
BTB/BTA10	BTB/BTA10	2.3 g	250	Bulk



# BTB/BTA10

## Discrete Triacs(Non-Isolated/Isolated)

Fig. 1 Maximum power dissipation versus RMS on-state current (full cycle).

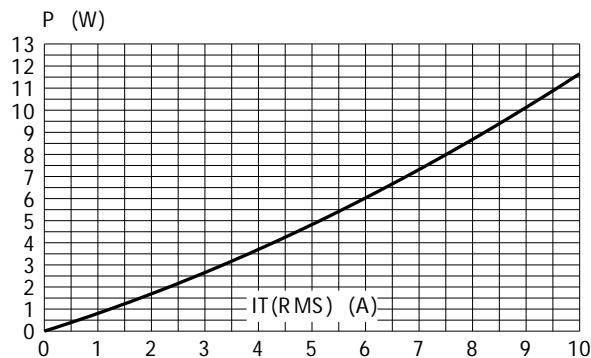


Fig. 2 RMS on-state current versus case temperature (full cycle).

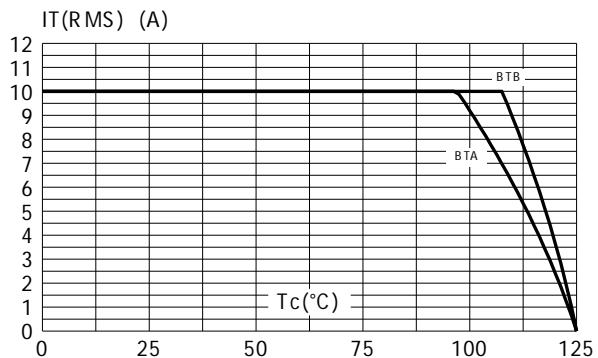


Fig. 3 Relative variation of thermal impedance versus pulse duration.

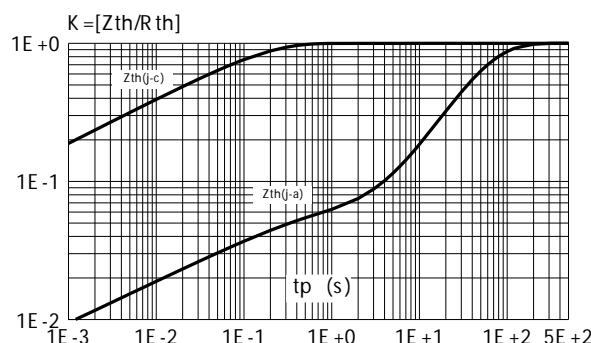


Fig. 5 Surge peak on-state current versus number of cycles.

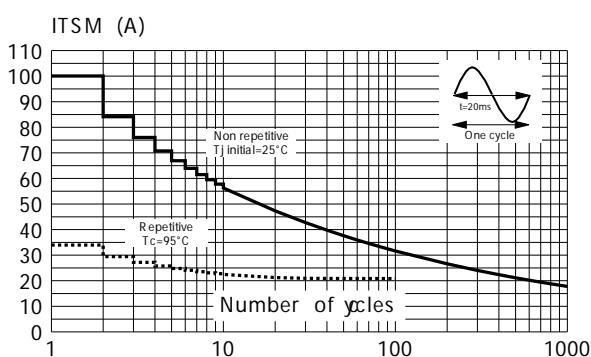


Fig. 4 On-state characteristics (maximum values).

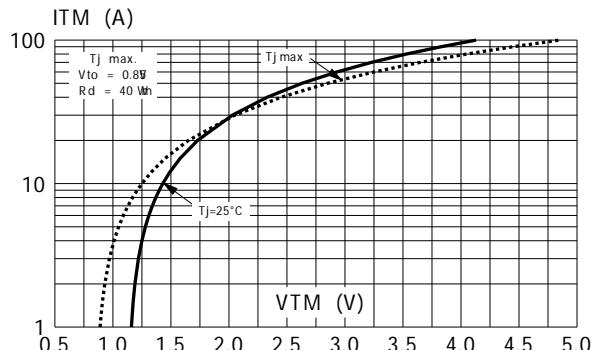
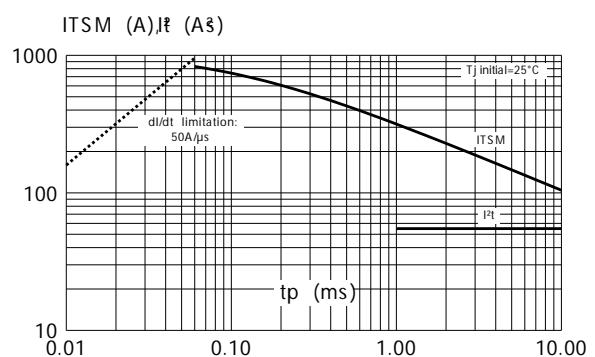


Fig. 6 Non-repetitive surge peak on-state current for a sinusoidal pulse with width tp < 10ms, and corresponding value of I<sup>2</sup>t.



# BTB/BTA10

## Discrete Triacs(Non-Isolated/Isolated)

Fig. 7 Relative variation of gate trigger current, holding current and latching current versus junction temperature (typical values).

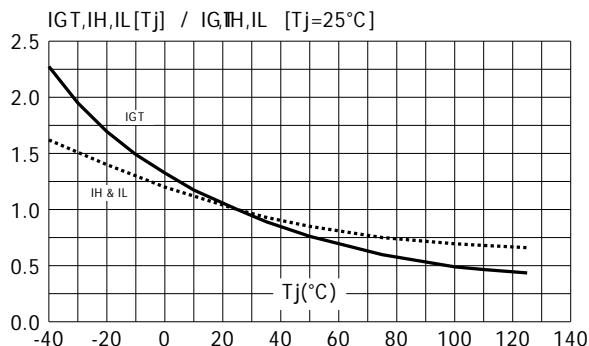


Fig. 8 Relative variation of critical rate of decrease of main current versus  $(dV/dt)_c$  (typical values).

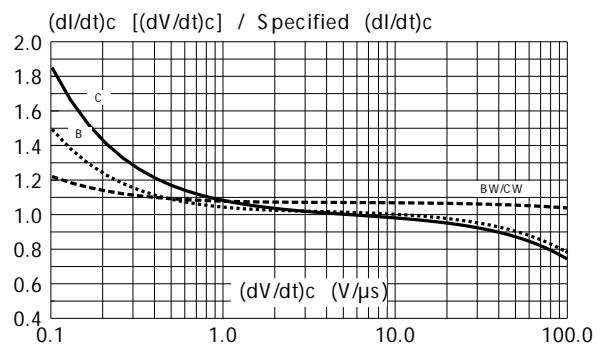


Fig. 9 Relative variation of critical rate of decrease of main current versus junction temperature.

